

Notice of References Cited	Application/Control No. 10/712,246	Applicant(s)/Patent Under Reexamination YU ET AL.	
	Examiner Thuy V. Tran	Art Unit 2821	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0142118 A1	07-2003	Funamoto et al.	345/691
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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